

# MBN750H65E2

Silicon N-channel IGBT 6500V E2 version

## FEATURES

- \* Soft switching behavior & low conduction loss: Soft low-injection punch-through High conductivity IGBT.
- \* Low driving power due to low input capacitance MOS gate.
- \* Low noise recovery: Ultra soft fast recovery diode.
- \* High thermal fatigue durability:  
( $\Delta T_c=70K$ ,  $N>30,000$ cycles)  
AlSiC base-plate/AlN substrate

## ABSOLUTE MAXIMUM RATINGS ( $T_c=25^\circ C$ )

| Item                           |                      | Symbol      | Unit       | MBN750H65E2         |
|--------------------------------|----------------------|-------------|------------|---------------------|
| Collector Emitter Voltage      | $T_{vj}=125^\circ C$ | $V_{CES}$   | V          | 6,500               |
|                                | $T_{vj}=25^\circ C$  |             |            | 6,500               |
|                                | $T_{vj}=-40^\circ C$ |             |            | 6,000               |
| Gate Emitter Voltage           |                      | $V_{GES}$   | V          | $\pm 20$            |
| Collector Current              | DC                   | $I_C$       | A          | 750                 |
|                                | 1ms                  | $I_{CRM}$   |            | 1,500               |
| Forward Current                | DC                   | $I_F$       | A          | 750                 |
|                                | 1ms                  | $I_{FRM}$   |            | 1,500               |
| Operating Junction Temperature |                      | $T_{vj op}$ | $^\circ C$ | -40 ~ +125          |
| Storage Temperature            |                      | $T_{stg}$   | $^\circ C$ | -50 ~ +125          |
| Isolation Voltage              |                      | $V_{ISO}$   | $V_{RMS}$  | 10,200(AC 1 minute) |
| Screw Torque                   | Terminals (M4/M8)    | -           | N·m        | 2/10 (1)            |
|                                | Mounting (M6)        | -           |            | 6 (2)               |

Notes: (1) Recommended Value  $1.8 \pm 0.2/9 \pm 1 N \cdot m$

(2) Recommended Value  $5.5 \pm 0.5 N \cdot m$

## ELECTRICAL CHARACTERISTICS

| Item                                 | Symbol          | Unit      | Min.  | Typ. | Max. | Test Conditions                                                                                              |
|--------------------------------------|-----------------|-----------|-------|------|------|--------------------------------------------------------------------------------------------------------------|
| Collector Emitter Cut-Off Current    | $I_{CES}$       | mA        | -     | -    | 25   | $V_{CE}=6,500V$ , $V_{GE}=0V$ , $T_{vj}=25^\circ C$                                                          |
| Gate Emitter Leakage Current         | $I_{GES}$       | nA        | -500  | -    | +500 | $V_{CE}=6,500V$ , $V_{GE}=0V$ , $T_{vj}=125^\circ C$                                                         |
| Collector Emitter Saturation Voltage | $V_{CEsat}$     | V         | -     | 3.2  | -    | $I_C=750A$ , $V_{GE}=15V$ , $T_{vj}=25^\circ C$                                                              |
|                                      |                 |           | 3.4   | 4.3  | 5.2  | $I_C=750A$ , $V_{GE}=15V$ , $T_{vj}=125^\circ C$                                                             |
| Gate Emitter Threshold Voltage       | $V_{GE(th)}$    | V         | 5.8   | 6.3  | 6.8  | $V_{CE}=10V$ , $I_C=750mA$ , $T_{vj}=25^\circ C$                                                             |
| Input Capacitance                    | $C_{ies}$       | nF        | -     | 130  | -    | $V_{CE}=10V$ , $V_{GE}=0V$ , $f=100kHz$ , $T_{vj}=25^\circ C$                                                |
| Internal Gate Resistance             | $R_{G(int)}$    | $\Omega$  | -     | 0.7  | -    | $V_{CE}=10V$ , $V_{GE}=0V$ , $f=100kHz$ , $T_{vj}=25^\circ C$                                                |
| Turn On Delay Time                   | $t_{d(on)}$     | $\mu s$   | -     | 0.7  | -    | $V_{CC}=3,600V$ , $I_C=750A$                                                                                 |
| Rise Time                            | $t_r$           |           | 2.2   | 3.2  | 4.8  | $L_S=200nH$                                                                                                  |
| Turn Off Delay Time                  | $t_{d(off)}$    |           | -     | 3.3  | -    | $R_G=8.2\Omega$ (3)                                                                                          |
| Fall Time                            | $t_f$           |           | 2.2   | 3.1  | 4.7  | $V_{GE}=\pm 15V$ , $T_{vj}=125^\circ C$                                                                      |
| Forward Voltage Drop                 | $V_F$           | V         | -     | 3.6  | -    | $I_F=750A$ , $V_{GE}=0V$ , $T_{vj}=25^\circ C$                                                               |
|                                      |                 |           | 3.5   | 3.9  | 4.4  | $I_F=750A$ , $V_{GE}=0V$ , $T_{vj}=125^\circ C$                                                              |
| Reverse Recovery Time                | $t_{rr}$        | $\mu s$   | -     | 0.8  | 1.6  | $V_{CC}=3,600V$ , $I_F=750A$ , $L_S=200nH$<br>$T_{vj}=125^\circ C$                                           |
| Turn On Loss                         | $E_{on(10\%)}$  | J/P       | -     | 4.9  | 6.4  | $V_{CC}=3,600V$ , $I_C=750A$ , $L_S=200nH$<br>$R_G=8.2\Omega$ (3)<br>$V_{GE}=\pm 15V$ , $T_{vj}=125^\circ C$ |
|                                      | $E_{on(full)}$  |           | -     | 5.5  | -    |                                                                                                              |
| Turn Off Loss                        | $E_{off(10\%)}$ | J/P       | -     | 3.9  | 5.1  |                                                                                                              |
|                                      | $E_{off(full)}$ |           | -     | 4.2  | -    |                                                                                                              |
| Reverse Recovery Loss                | $E_{rr(10\%)}$  | J/P       | -     | 2.1  | 2.7  |                                                                                                              |
|                                      | $E_{rr(full)}$  |           | -     | 2.3  | -    |                                                                                                              |
| Short Circuit Pulse Width            | $t_{sc}$        | $\mu s$   | 10    | -    | -    | $V_{CC}=4,500V$ , $L_S=200nH$<br>$R_G(on/off)=8.2/82\Omega$ , $V_{GE}=\pm 15V$ , $T_{vj}=25^\circ C$         |
| Partial discharge extinction voltage | $V_e$           | $V_{RMS}$ | 5,100 | -    | -    | $f=50Hz$ , $Q_{PD} \leq 10pC$ (acc. to IEC 61287)                                                            |

Notes: (3)  $R_G$  value is a test condition value for evaluation, not recommended value.

Please, determine the suitable  $R_G$  value by measuring switching behaviors.

- \* Please contact our representatives at order.
- \* For improvement, specifications are subject to change without notice.
- \* For actual application, please confirm this spec sheet is the newest revision.
- \* ELECTRICAL CHARACTERISTIC items shown in above table are according to IEC 60747-2 and IEC 60747-9.

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THERMAL CHARACTERISTICS

| Item                      |      | Symbol        | Unit | Min. | Typ.  | Max.  | Test Conditions                                                                    |
|---------------------------|------|---------------|------|------|-------|-------|------------------------------------------------------------------------------------|
| Thermal Impedance         | IGBT | $R_{th(j-c)}$ | K/W  | -    | -     | 0.009 | Junction to case                                                                   |
|                           | FWD  | $R_{th(f-c)}$ |      | -    | -     | 0.017 |                                                                                    |
| Contact Thermal Impedance |      | $R_{th(c-f)}$ | K/W  | -    | 0.005 | -     | Case to fin ( $\lambda$ grease = 1W/(m·K)<br>heat-sink flatness $\leq$ 50 $\mu$ m) |

MODULE MECHANICAL CHARACTERISTICS

| Item                             |           | Unit | Characteristics        | Conditions                     |
|----------------------------------|-----------|------|------------------------|--------------------------------|
| Weight                           |           | g    | 1,550                  |                                |
| Stray inductance in module       | LS(CM-EM) | nH   | 14                     | Collector-main to Emitter-main |
| Comparative Tracking Index (CTI) |           | -    | 600                    |                                |
| Module base plate Material       |           | -    | Al-SiC                 |                                |
| Baseplate Thickness              |           | mm   | 5                      |                                |
| Insulation plate Material        |           | -    | Al N                   |                                |
| Terminal Surface treatment       |           | -    | Ni plating             |                                |
| Case Material                    |           | -    | Poly-Phenylene Sulfide |                                |
| Fire and Smoke Category          |           | -    | I2 / F3                | NFF 16-102                     |

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## DEFINITION OF TEST CIRCUIT

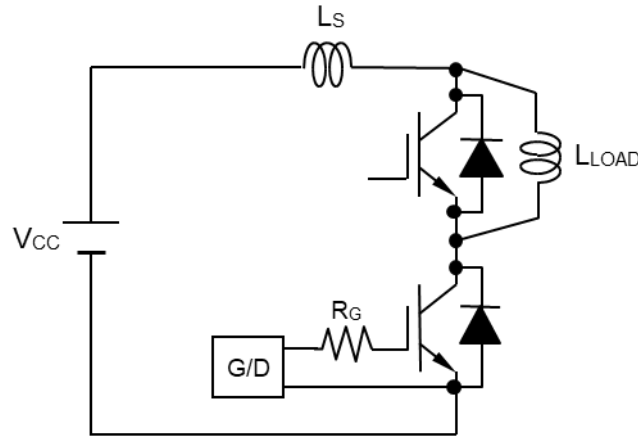


Fig.1 Switching test circuit

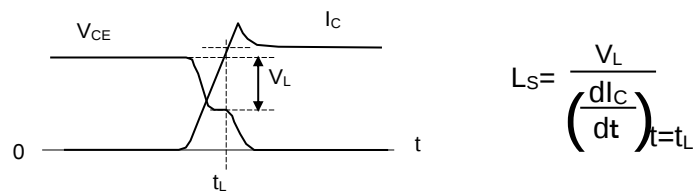


Fig.2 Definition of stray inductance

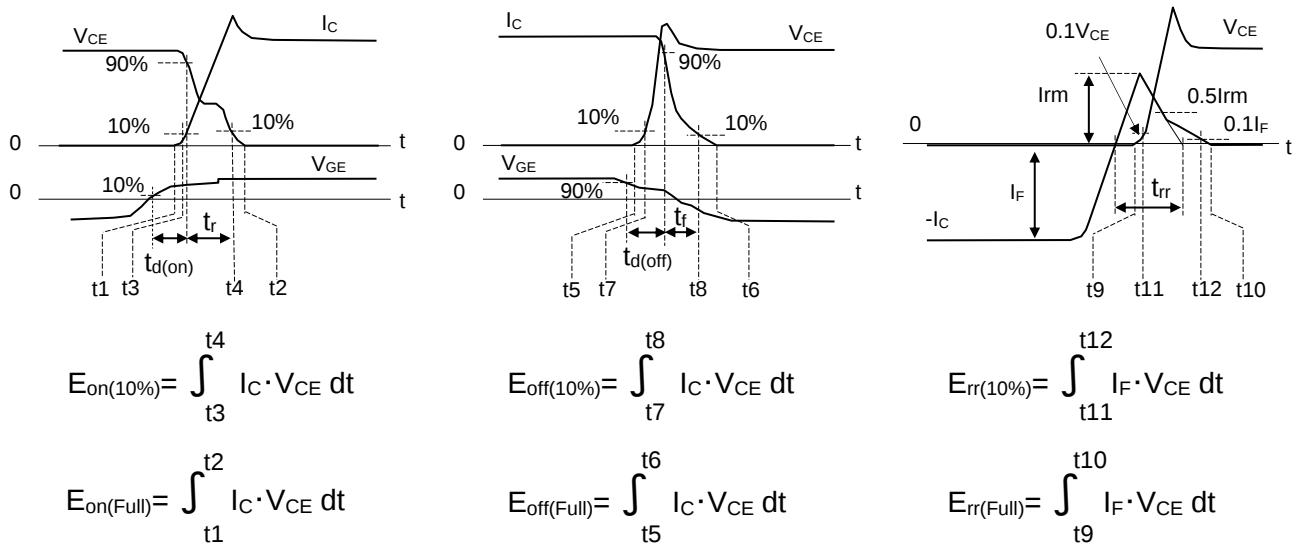
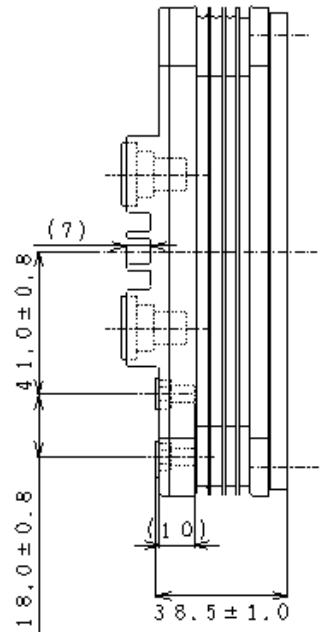
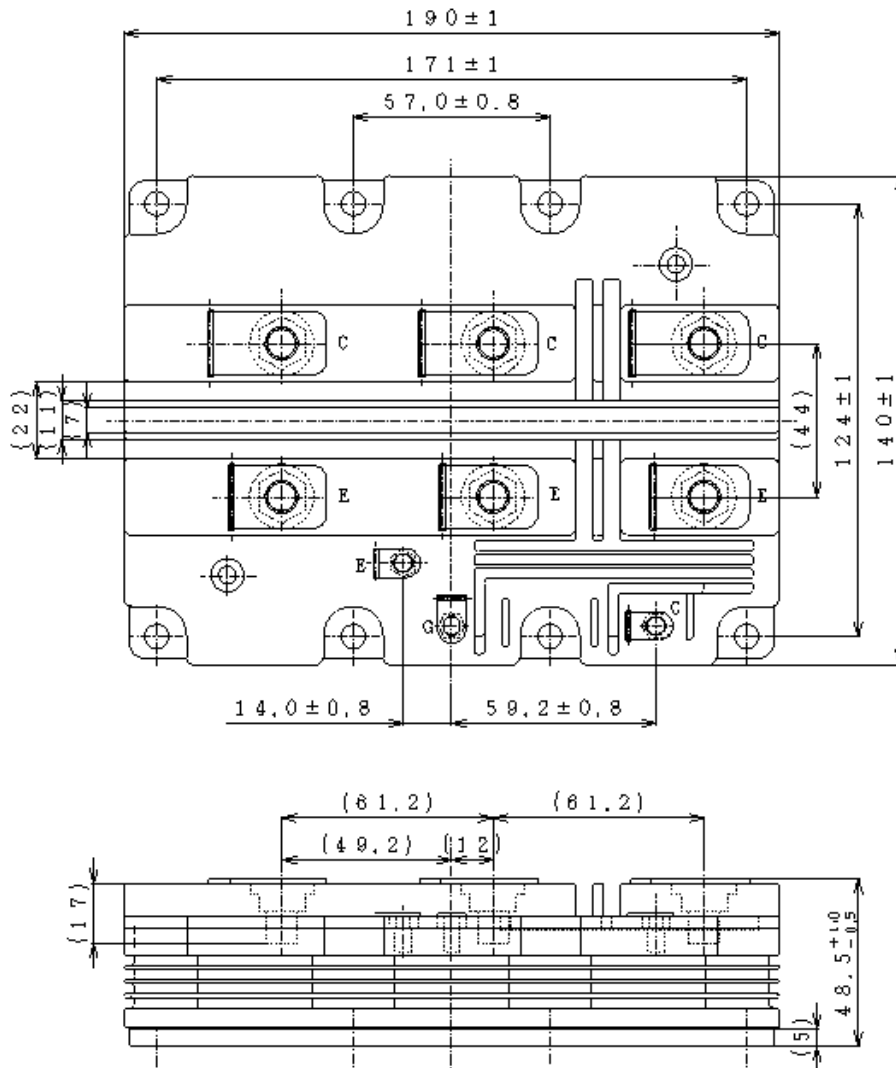


Fig.3 Definition of switching loss

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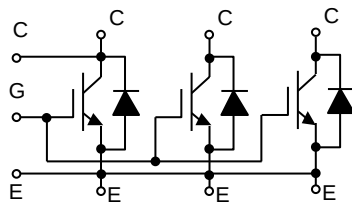
## OUTLINE DRAWING

Unit in mm

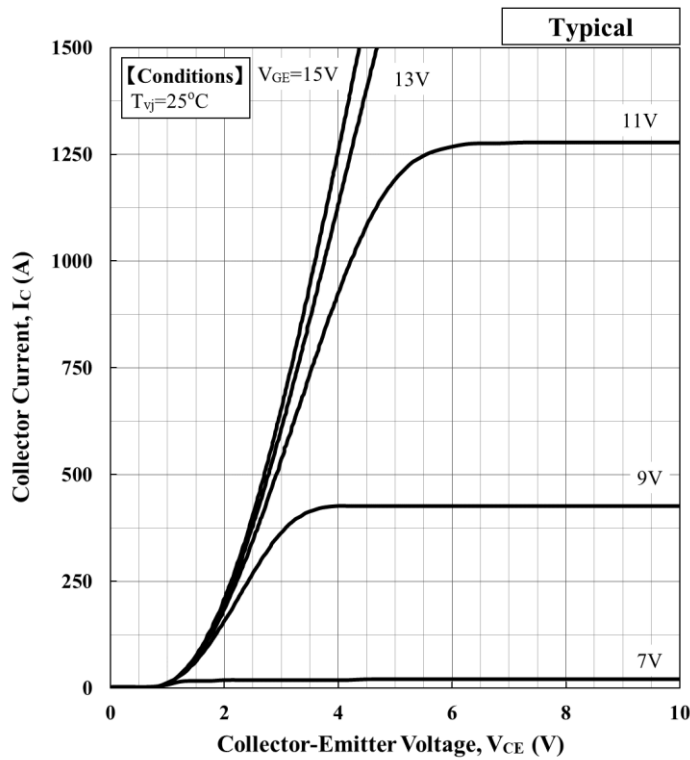


Weight: 1,550g

## CIRCUIT DIAGRAM

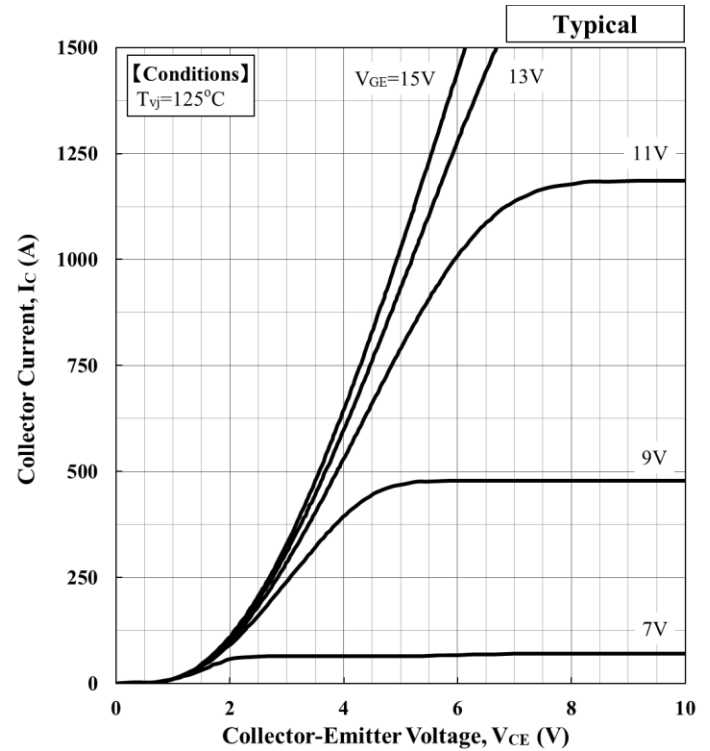


# MBN750H65E2



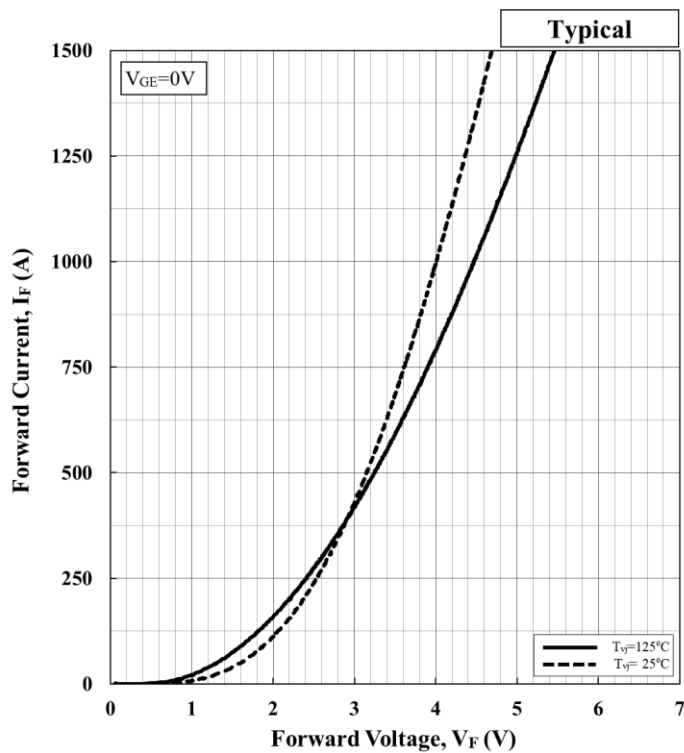
| $V_{CE}(sat)[V] = a_3 \cdot  I_c ^3 + a_2 \cdot  I_c ^2 + a_1 \cdot  I_c  + a_0$ |             |          |           |          |          |
|----------------------------------------------------------------------------------|-------------|----------|-----------|----------|----------|
| Temp.[°C]                                                                        | $V_{GE}[V]$ | $a_3$    | $a_2$     | $a_1$    | $a_0$    |
| 25                                                                               | 15          | 4.88E-10 | -1.71E-06 | 3.49E-03 | 1.32E+00 |

Collector Current vs. Collector Emitter Voltage



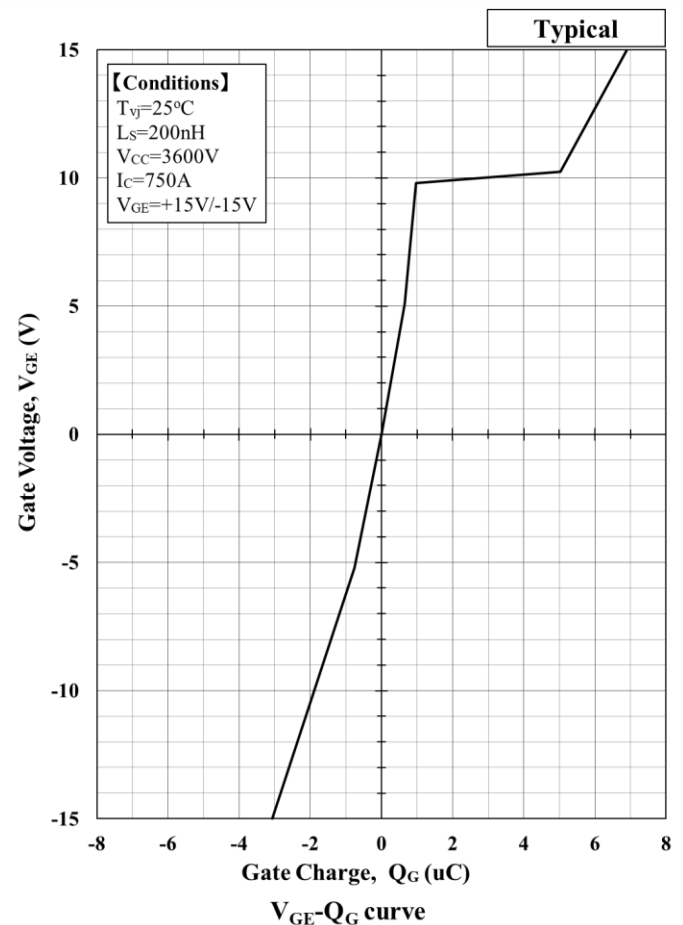
| $V_{CE}(sat)[V] = a_3 \cdot  I_c ^3 + a_2 \cdot  I_c ^2 + a_1 \cdot  I_c  + a_0$ |             |          |           |          |          |
|----------------------------------------------------------------------------------|-------------|----------|-----------|----------|----------|
| Temp.[°C]                                                                        | $V_{GE}[V]$ | $a_3$    | $a_2$     | $a_1$    | $a_0$    |
| 125                                                                              | 15          | 7.26E-10 | -2.51E-06 | 5.23E-03 | 1.50E+00 |

Collector Current vs. Collector Emitter Voltage

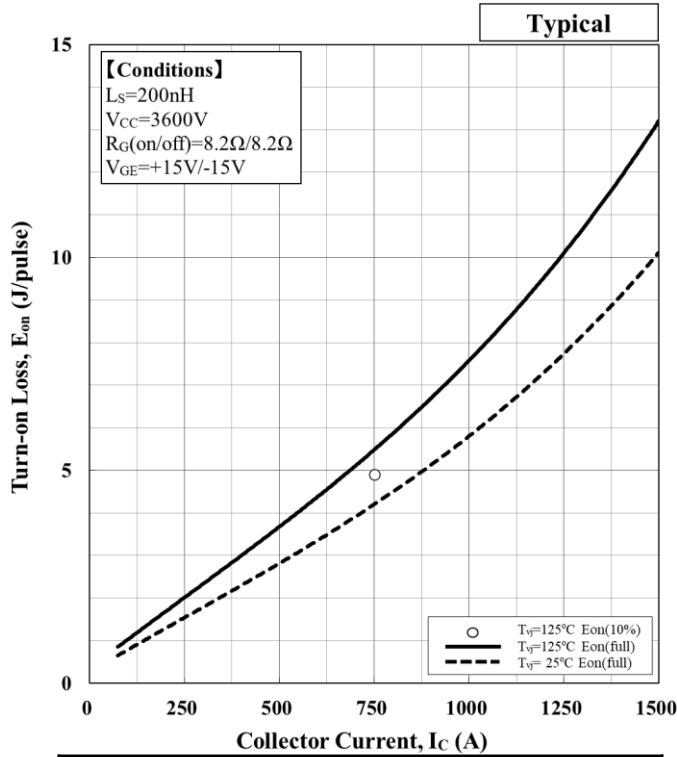


| $V_F[V] = a_3 \cdot  I_F ^3 + a_2 \cdot  I_F ^2 + a_1 \cdot  I_F  + a_0$ |          |           |          |          |
|--------------------------------------------------------------------------|----------|-----------|----------|----------|
| Temp.[°C]                                                                | $a_3$    | $a_2$     | $a_1$    | $a_0$    |
| 25                                                                       | 6.82E-10 | -2.40E-06 | 4.13E-03 | 1.60E+00 |
| 125                                                                      | 7.26E-10 | -2.65E-06 | 5.17E-03 | 1.23E+00 |

Forward Voltage of free-wheeling diode

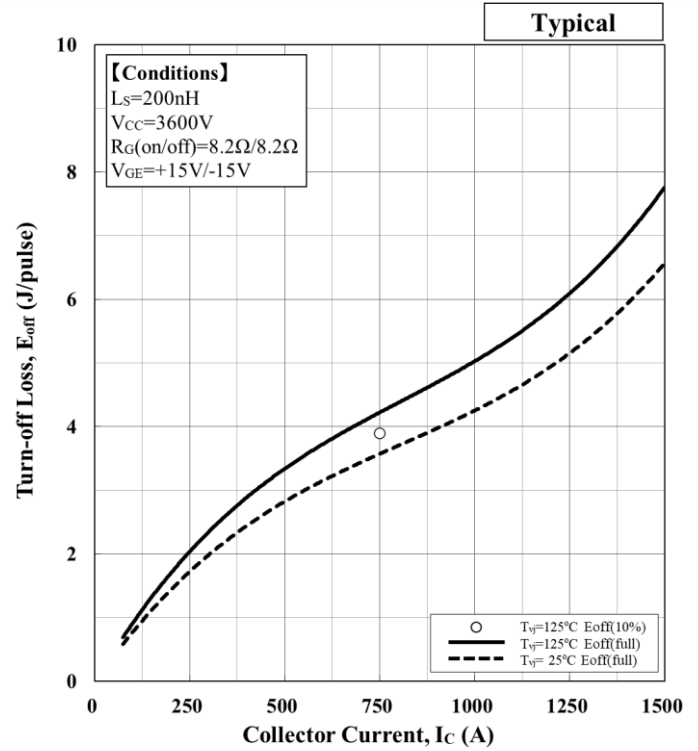


# MBN750H65E2



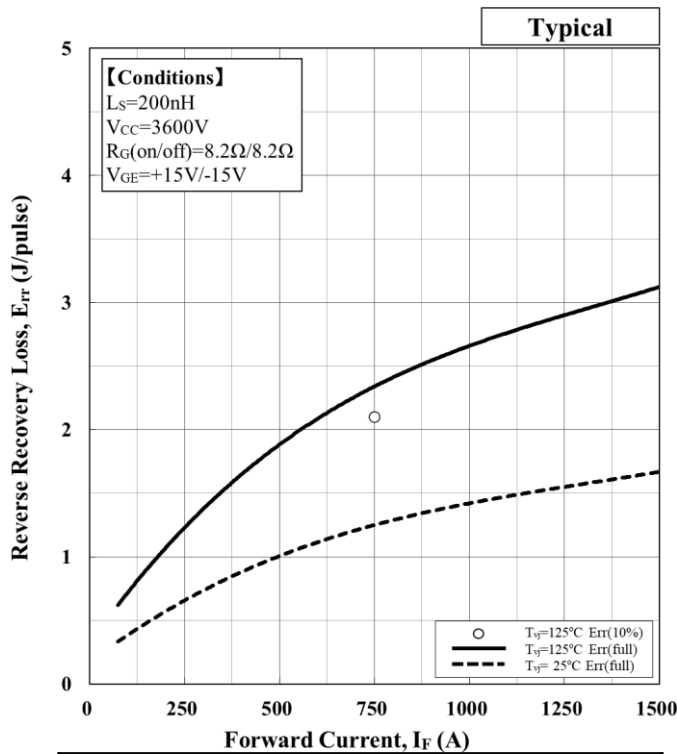
| $E [J] = a_3 \cdot  I_C ^3 + a_2 \cdot  I_C ^2 + a_1 \cdot  I_C  + a_0$ |          |           |          |          |
|-------------------------------------------------------------------------|----------|-----------|----------|----------|
| Temp.[°C]                                                               | $a_3$    | $a_2$     | $a_1$    | $a_0$    |
| 25                                                                      | 1.17E-09 | -8.75E-07 | 5.24E-03 | 2.68E-01 |
| 125                                                                     | 1.53E-09 | -1.14E-06 | 6.84E-03 | 3.50E-01 |

Turn-on loss vs. Collector current



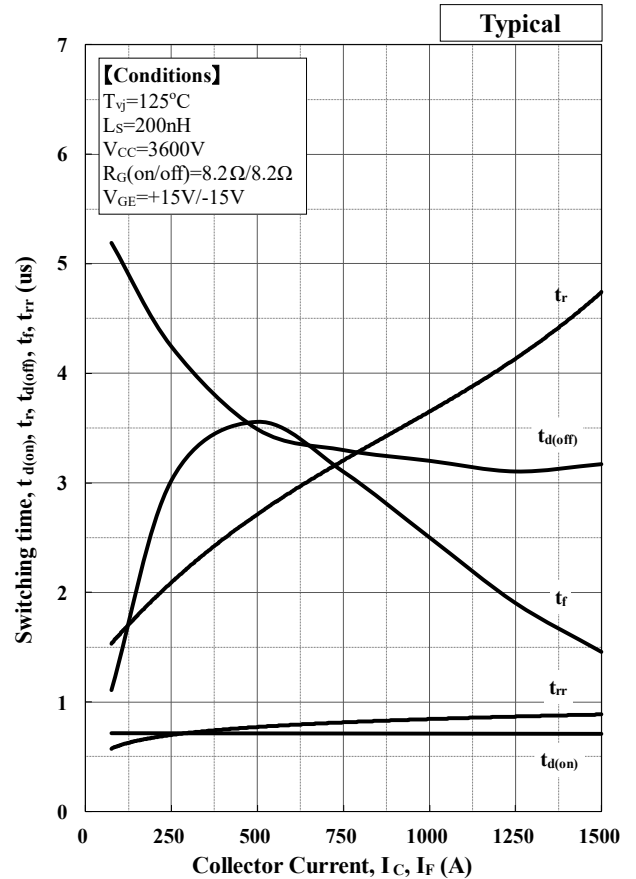
| $E [J] = a_3 \cdot  I_C ^3 + a_2 \cdot  I_C ^2 + a_1 \cdot  I_C  + a_0$ |          |           |          |           |
|-------------------------------------------------------------------------|----------|-----------|----------|-----------|
| Temp.[°C]                                                               | $a_3$    | $a_2$     | $a_1$    | $a_0$     |
| 25                                                                      | 3.07E-09 | -7.44E-06 | 8.65E-03 | -2.08E-02 |
| 125                                                                     | 3.63E-09 | -8.80E-06 | 1.02E-02 | -2.46E-02 |

Turn-off loss vs. Collector current



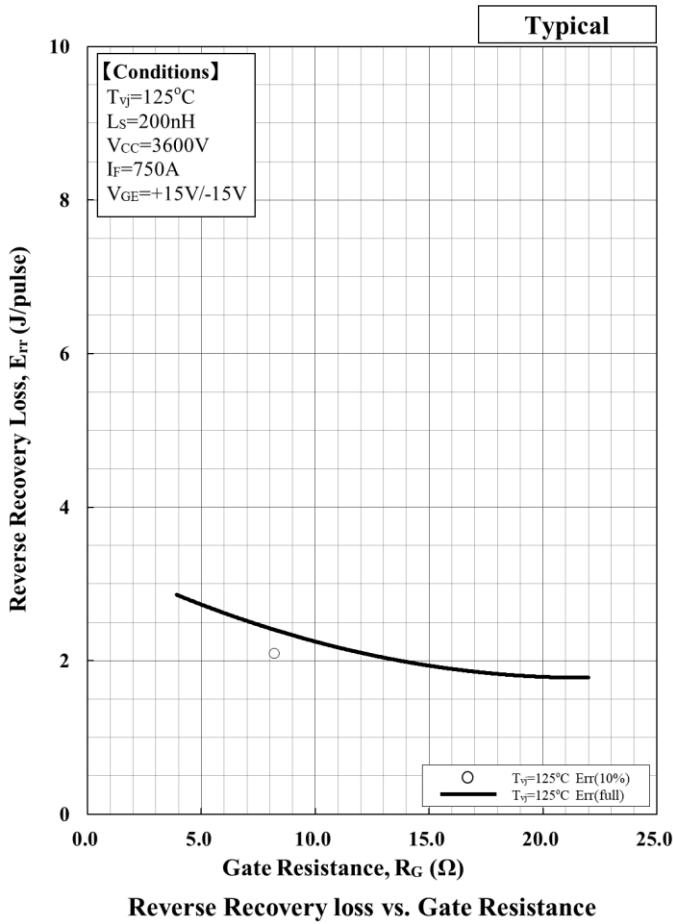
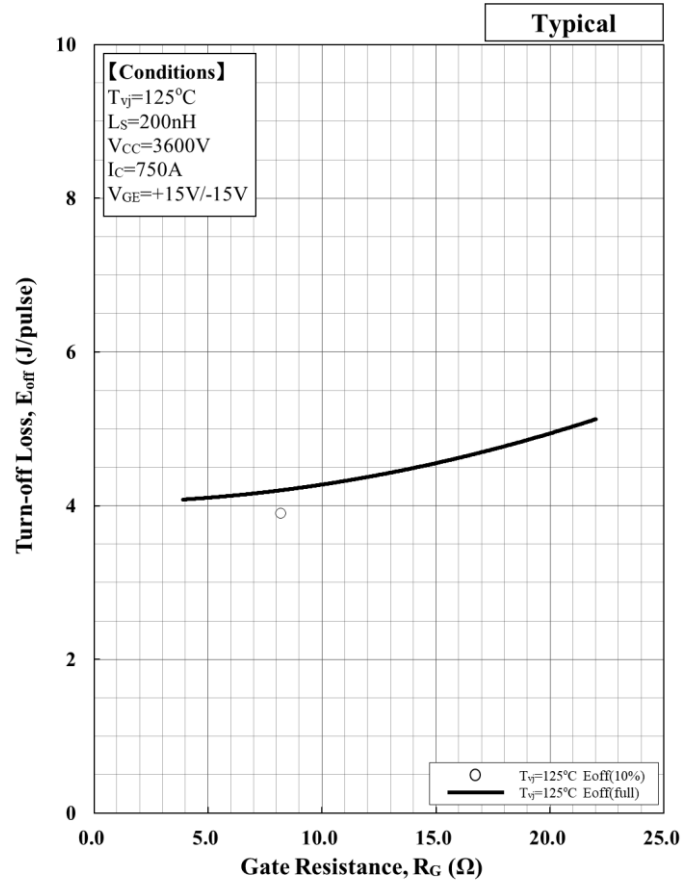
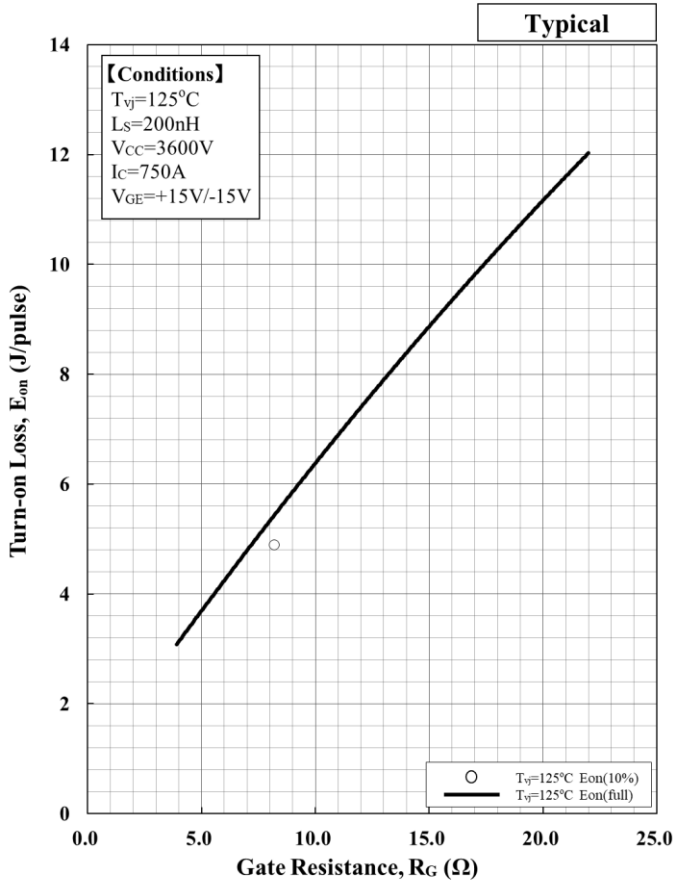
| $E [J] = a_3 \cdot  I_F ^3 + a_2 \cdot  I_F ^2 + a_1 \cdot  I_F  + a_0$ |          |           |          |          |
|-------------------------------------------------------------------------|----------|-----------|----------|----------|
| Temp.[°C]                                                               | $a_3$    | $a_2$     | $a_1$    | $a_0$    |
| 25                                                                      | 3.39E-10 | -1.35E-06 | 2.26E-03 | 1.70E-01 |
| 125                                                                     | 6.34E-10 | -2.53E-06 | 4.23E-03 | 3.19E-01 |

Recovery loss vs. Forward current

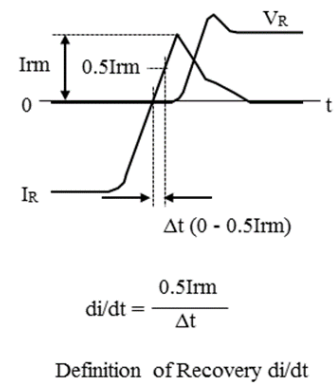
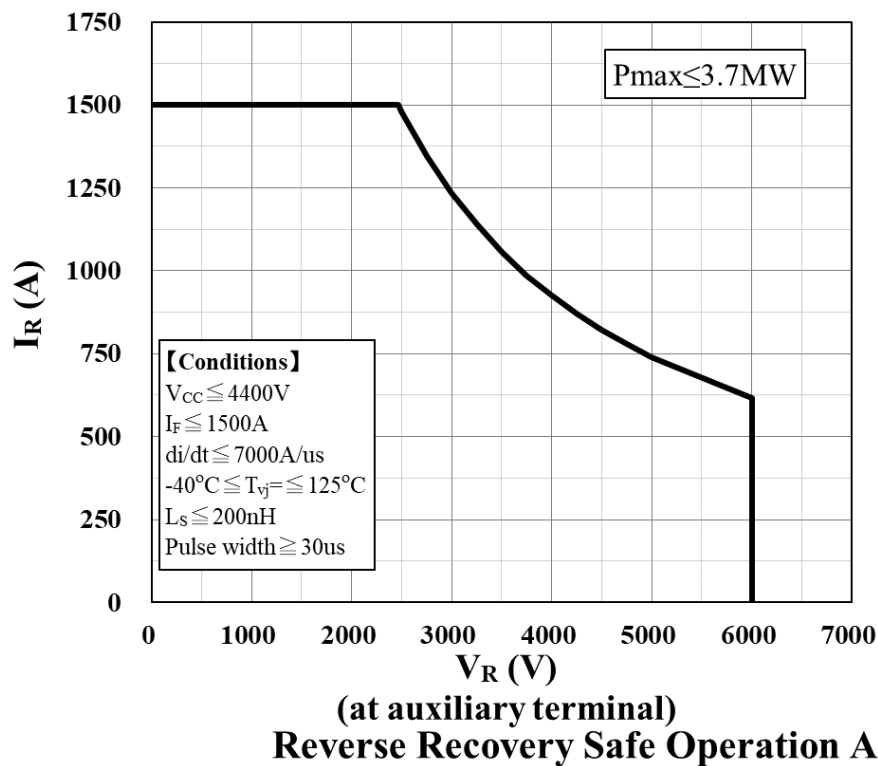
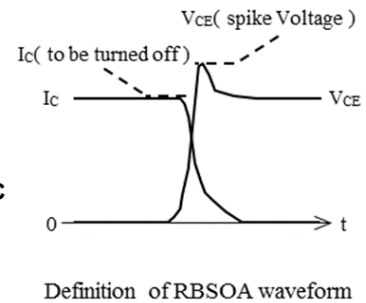
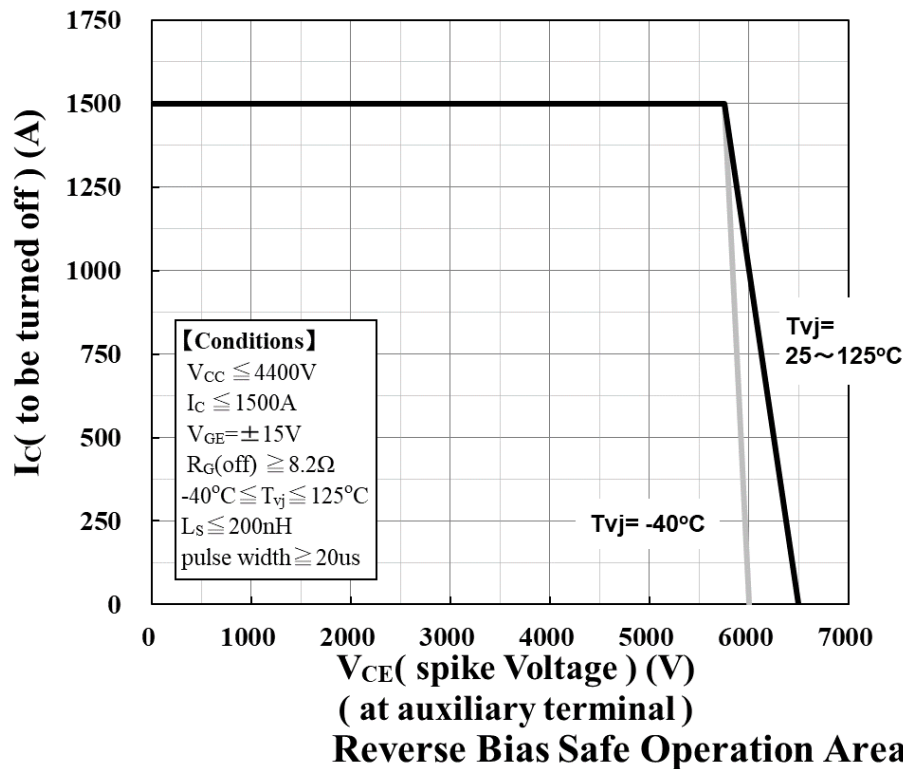


Switching time vs. Collector Current

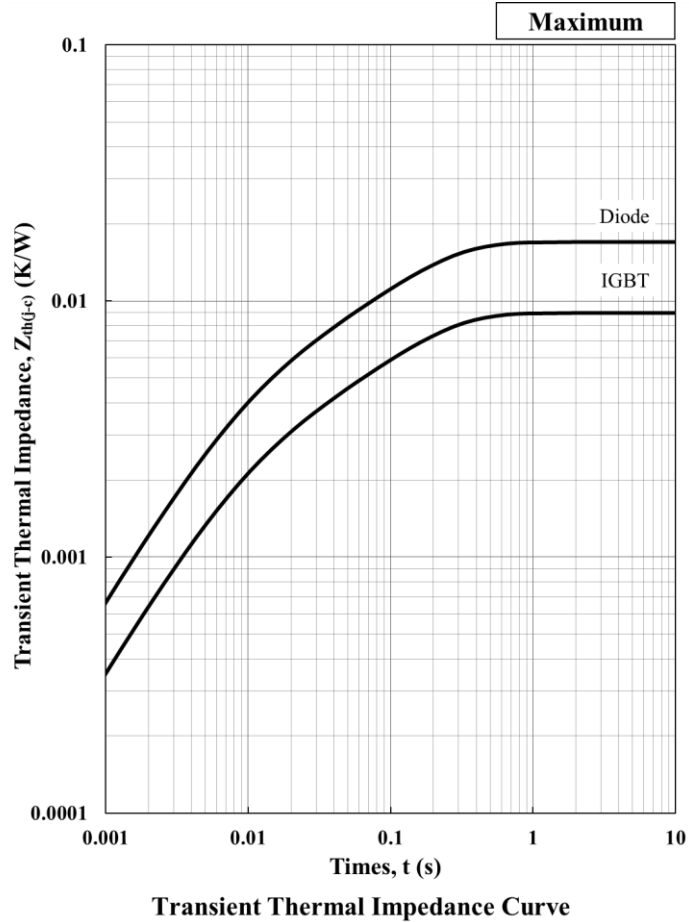
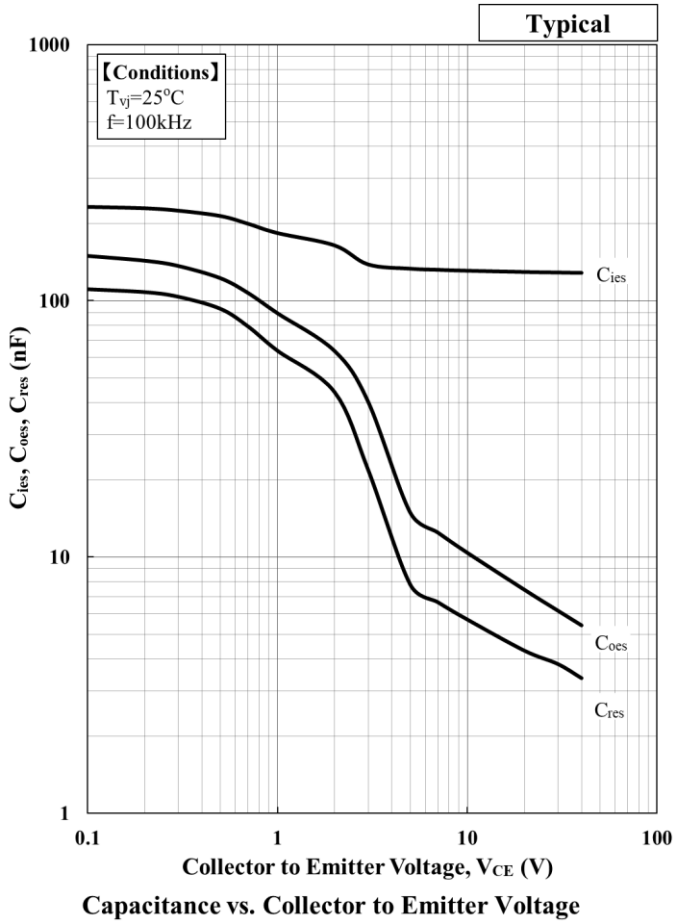
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Foster model lumped circuit constant

| n               | 1        | 2        | 3        | 4        | Unit  |
|-----------------|----------|----------|----------|----------|-------|
| R th, IGBT [n]  | 5.61E-03 | 1.78E-03 | 1.56E-03 | 4.97E-05 | [K/W] |
| C th, IGBT [n]  | 2.92E+01 | 1.55E+01 | 4.28E+00 | 1.49E+01 | [J/K] |
| R th, Diode [n] | 1.06E-02 | 3.41E-03 | 2.92E-03 | 1.00E-04 | [K/W] |
| C th, Diode [n] | 1.55E+01 | 8.07E+00 | 2.29E+00 | 7.41E+00 | [J/K] |

Cauer model lumped circuit constant

| n               | 1        | 2        | 3        | 4        | Unit  |
|-----------------|----------|----------|----------|----------|-------|
| R th, IGBT [n]  | 1.25E-03 | 1.88E-03 | 2.79E-03 | 3.08E-03 | [K/W] |
| C th, IGBT [n]  | 2.50E+00 | 1.19E+00 | 1.16E+01 | 3.21E+01 | [J/K] |
| R th, Diode [n] | 2.29E-03 | 3.63E-03 | 5.27E-03 | 5.81E-03 | [K/W] |
| C th, Diode [n] | 1.32E+00 | 6.42E-01 | 6.08E+00 | 1.71E+01 | [J/K] |

Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

| Material                    | Contained part |
|-----------------------------|----------------|
| Lead (Pb) and its compounds | Solder         |

# MBN750H65E2

## Minebea POWER SEMICONDUCTORS

### Notices

1. Since mishandling of semiconductor devices may cause malfunctions, please be sure to read "Precautions for Safe Use and Notices" in the individual brochure before use.
2. When designing an electronic circuit using semiconductor devices, please do not exceed the absolute maximum rating specified for the device under any external fluctuations. And for pulse applications, please also do not exceed the "Safe Operating Area (SOA)".
3. Semiconductor devices may sometimes break down by accidental or unexpected surge voltage, so please be careful about the safety design such as redundant design and malfunction prevention design which don't cause the damage expand even if they break down.
4. In cases where extremely high reliability is required (such as use in nuclear power control, aerospace and aviation, traffic equipment, life-support-related medical equipment, fuel control equipment and various kinds of safety equipment), safety should be ensured by using semiconductor devices that feature assured safety or by means of users' fail-safe precautions or other arrangement. Or consult with MPSD's sales department staff. (When semiconductor devices fail, as a result the semiconductor devices or wiring, wiring pattern may smoke, ignite, or the semiconductor devices themselves may burst.)
5. A semi-processed article is done now using solder which contains lead inside the semiconductor devices. There is possibility of the regulation substance depend on the applied models, so please check before using.
6. This specification is a material for component selection, which describes specifications of power semiconductor devices (hereinafter referred to as products), characteristic charts, and external dimension drawings.
7. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact with Minebea power semiconductor sales department for the latest version of this data sheets.
8. For handling other than described in this manual, follow the handling instructions (IGBT-HI-00002).

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## Minebea POWER SEMICONDUCTORS

### Usage

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